

<b>Notice of References Cited</b>	Application/Control No. 10/072,401		Applicant(s)/Patent Under Reexamination BUCKNALL ET AL.	
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*	B	US-2007/0226621 A1	09-2007	Dayan et al.	715/706
*	C	US-6,211,881 B1	04-2001	Gabler et al.	345/418
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	K	US-			
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**NON-PATENT DOCUMENTS**

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